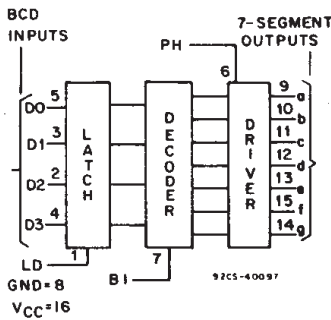


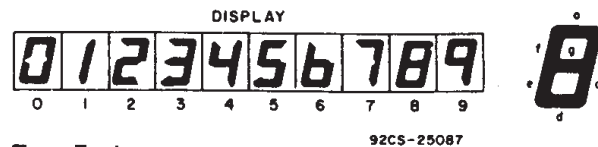
# CD54/74HC4543 CD54/74HCT4543

File Number 1822

## High-Speed CMOS Logic



### BCD-to-7 Segment Latch/ Decoder/Driver for LCDs



- Type Features:**
- Input latches for BCD code storage
  - Blanking capability
  - Phase input for complementing outputs

The RCA CD54/74HC4543 and CD54/74HCT4543 high-speed silicon-gate devices are BCD-to-7 segment latch/decoder/drivers designed primarily for directly driving liquid-crystal displays. They have an active-high disable input (LD), an active high blanking input (BI) and a phase input (PH) to which a square wave is applied for liquid-crystal applications. This square wave is also applied to the backplane of the liquid-crystal display.

These devices can also be used, in conjunction with current amplifying devices, for driving LEDs, incandescent, fluorescent, and gas-discharge displays. For these applications the phase input provides a means for obtaining active-high or active-low segment outputs. (See Function Table.)

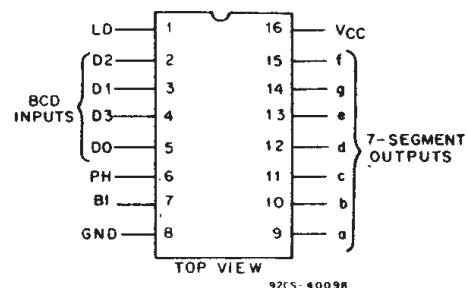
The CD54HC/HCT4543 are supplied in 16-lead ceramic dual-in-line frit-seal packages (F suffix). The CD74HC/HCT-4543 are supplied in 16-lead dual-in-line plastic packages (E suffix) and in 16-lead dual-in-line surface-mount plastic packages (M suffix). Both types are also available in chip form (H suffix).

- Family Features:**
- Fanout (over temperature range):  
Standard outputs - 10 LSTTL loads  
Bus driver outputs - 15 LSTTL loads
  - Wide operating temperature range:  
CD74HC/HCT: -40 to +85°C
  - Balanced propagation delay and transition times
  - Significant power reduction compared to LSTTL logic ICs
  - Alternate source is Philips/Signetics
  - CD54HC/CD74HC types:  
2 to 6 V operation  
High noise immunity:  
 $N_{IL}=30\%$ ,  $N_{IH}=30\%$  of  $V_{CC}$ ; @  $V_{CC}=5 V$
  - CD54HCT/CD74HCT types:  
4.5 to 5.5 V operation  
Direct LSTTL input logic compatibility  
 $V_{IL}=0.8 V$  max.,  $V_{IH}=2 V$  min.  
CMOS input compatibility  
 $I_L \leq 1 \mu A$  @  $V_{OL}$ ,  $V_{OH}$

### FUNCTION TABLE

INPUTS							OUTPUTS							DISPLAY
LD	BI	PH	D3	D2	D1	D0	a	b	c	d	e	f	g	
X	H	L	X	X	X	X	L	L	L	L	L	L	L	Blank
H	L	L	L	L	L	L	H	H	H	H	H	H	H	0
H	L	L	L	L	L	H	L	H	H	L	L	L	L	1
H	L	L	L	L	H	L	H	H	L	H	L	L	H	2
H	L	L	L	L	H	H	H	H	H	L	L	H	H	3
H	L	L	L	H	L	L	L	H	L	L	L	H	H	4
H	L	L	L	H	L	H	H	L	H	L	H	H	H	5
H	L	L	L	H	H	L	H	L	H	H	H	H	H	6
H	L	L	L	H	H	H	H	H	L	L	L	L	L	7
H	L	L	H	L	L	L	H	H	H	H	H	H	H	8
H	L	L	H	L	L	H	H	H	H	H	L	L	L	9
H	L	L	H	L	H	L	L	L	L	L	L	L	L	Blank
H	L	L	H	L	H	H	L	L	L	L	L	L	L	Blank
H	L	L	H	L	H	L	L	L	L	L	L	L	L	Blank
H	L	L	H	L	H	H	L	L	L	L	L	L	L	Blank
H	L	L	H	H	H	L	L	L	L	L	L	L	L	Blank
H	L	L	H	H	H	H	L	L	L	L	L	L	L	Blank
L	L	L	X	X	X	X	L	L	L	L	L	L	L	..
as above	H		as above											as above

\*\*Depends upon the BCD code previously applied when LD = High



### TERMINAL ASSIGNMENT

This data sheet is applicable to the CD74HCT4543. The CD54HC4543 and CD54HCT4543 were not acquired from Harris Semiconductor. See SCHS217 for information on the CD74HCT4543.

# CD54/74HC4543 CD54/74HCT4543

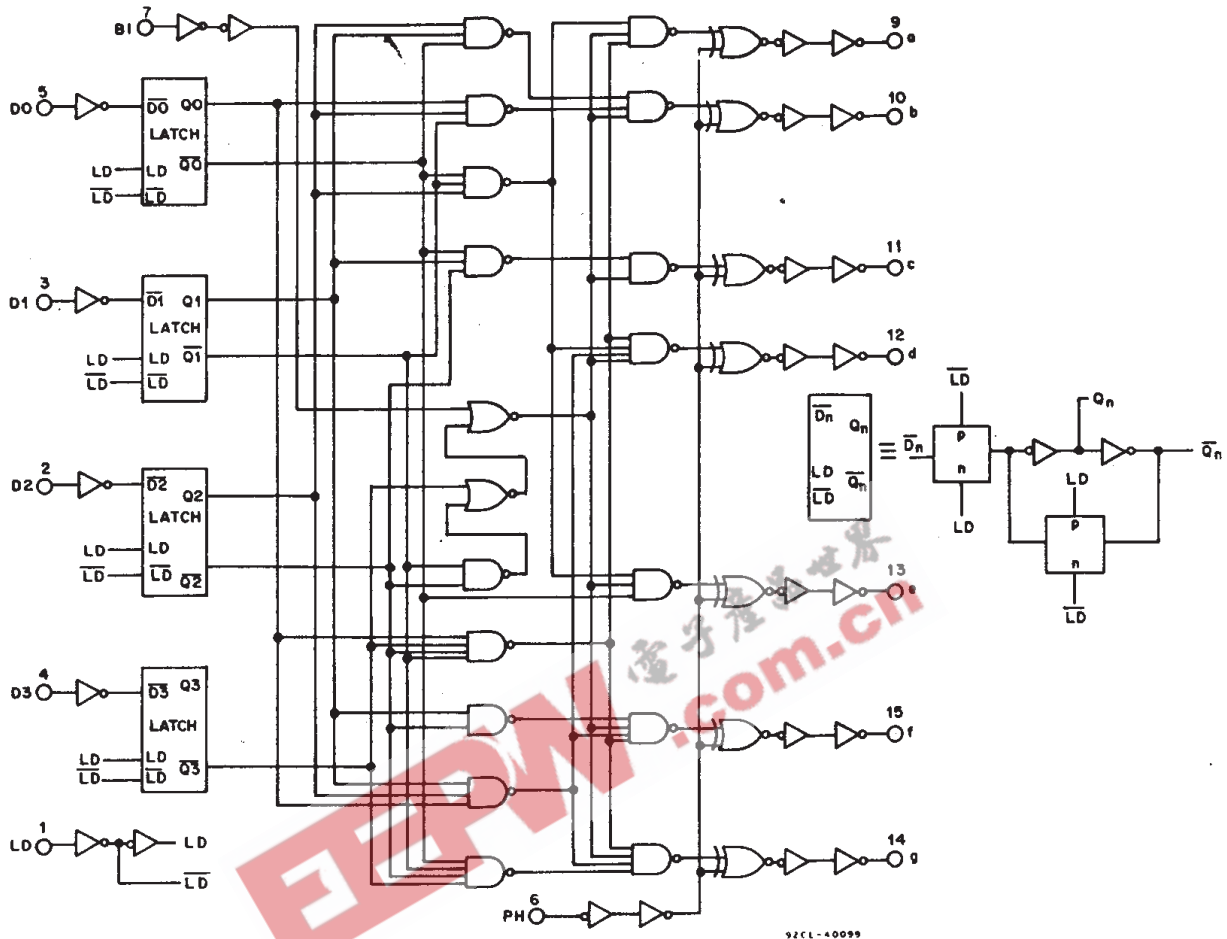


Fig. 1 - Logic diagram.

**MAXIMUM RATINGS, Absolute-Maximum Values:**

DC SUPPLY-VOLTAGE, (V <sub>CC</sub> ):	
(Voltages referenced to ground)	..... -0.5 to +7 V
DC INPUT DIODE CURRENT, I <sub>IK</sub> (FOR V <sub>i</sub> < -0.5 V OR V <sub>i</sub> > V <sub>CC</sub> +0.5 V)	..... ±20 mA
DC OUTPUT DIODE CURRENT, I <sub>OK</sub> (FOR V <sub>o</sub> < -0.5 V OR V <sub>o</sub> > V <sub>CC</sub> +0.5 V)	..... ±20 mA
DC DRAIN CURRENT, PER OUTPUT (I <sub>o</sub> ) (FOR -0.5 V < V <sub>o</sub> < V <sub>CC</sub> +0.5 V)	..... ±25 mA
DC V <sub>CC</sub> OR GROUND CURRENT (I <sub>CC</sub> )	..... ±50 mA
POWER DISSIPATION PER PACKAGE (P <sub>D</sub> ):	
For T <sub>A</sub> = -40 to +60°C (PACKAGE TYPE E)	..... 500 mW
For T <sub>A</sub> = +60 to +85°C (PACKAGE TYPE E)	..... Derate Linearly at 8 mW/°C to 300 mW
For T <sub>A</sub> = -55 to +100°C (PACKAGE TYPE F,H)	..... 500 mW
For T <sub>A</sub> = +100 to +125°C (PACKAGE TYPE F,H)	..... Derate Linearly at 8 mW/°C to 300 mW
For T <sub>A</sub> = -40 to +70°C (PACKAGE TYPE M)	..... 400 mW
For T <sub>A</sub> = +70 to +125°C (PACKAGE TYPE M)	..... Derate Linearly at 6 mW/°C to 70 mW
OPERATING-TEMPERATURE RANGE (T <sub>A</sub> ):	
PACKAGE TYPE F,H	..... -55 to +125°C
PACKAGE TYPE E,M	..... -40 to +85°C
STORAGE TEMPERATURE (T <sub>stg</sub> )	..... -65 to +150°C
LEAD TEMPERATURE (DURING SOLDERING):	
At distance 1/16 ± 1/32 in. (1.59 ± 0.79 mm) from case for 10 s max.	..... +265°C
Unit inserted into a PC Board (min. thickness 1/16 in., 1.59 mm) with solder contacting lead tips only	..... +300°C

Technical Data

# CD54/74HC4543

# CD54/74HCT4543

### RECOMMENDED OPERATING CONDITIONS

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	LIMITS		UNITS
	MIN.	MAX.	
Supply-Voltage Range (For T <sub>A</sub> =Full Package Temperature Range) V <sub>CC</sub> :* CD54/74HC Types CD54/74HCT Types	2 4.5	6 5.5	V
DC Input or Output Voltage, V <sub>I</sub> , V <sub>O</sub>	0	V <sub>CC</sub>	V
Operating Temperature, T <sub>A</sub> : CD74 Types CD54 Types	-40 -55	+85 +125	°C
Input Rise and Fall Times, t <sub>r</sub> , t <sub>f</sub> : at 2 V at 4.5 V at 6 V	0 0 0	1000 500 400	ns

\*Unless otherwise specified, all voltages are referenced to Ground.

### SWITCHING CHARACTERISTICS (V<sub>CC</sub>=5 V, T<sub>A</sub>=25°C, Input t<sub>r</sub>, t<sub>f</sub>=6 ns)

CHARACTERISTIC	C <sub>L</sub> (pF)	TYPICAL VALUES		UNITS
		HC	HCT	
Propagation Delay: D <sub>n</sub> to Output	t <sub>PLH</sub> t <sub>PHL</sub> 15	28	33	ns
LD to Output	t <sub>PLH</sub> t <sub>PHL</sub> 15	31	32	
BI to Output	t <sub>PLH</sub> t <sub>PHL</sub> 15	22	27	
PH to Output	t <sub>PLH</sub> t <sub>PHL</sub> 15	17	27	
Power Dissipation Capacitance*	C <sub>PD</sub>	52	54	pF

\*C<sub>PD</sub> is used to determine the dynamic power consumption, per package.

$$P_D = C_{PD} V_{CC}^2 f_i + \sum C_L V_{CC}^2 f_o$$

where f<sub>i</sub> = input frequency  
f<sub>o</sub> = output frequency  
C<sub>L</sub> = output load capacitance  
V<sub>CC</sub> = supply voltage.

### PRE-REQUISITE FOR SWITCHING FUNCTION

CHARACTERISTIC	TEST CONDITIONS V <sub>CC</sub> (V)	LIMITS												UNITS			
		25°C				-40°C to +85°C				-55°C to +125°C							
		HC		HCT		74HC		74HCT		54HC		54HCT					
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.				
Setup Time, D <sub>n</sub> to LD	t <sub>SU</sub>	2	60	—	—	—	—	75	—	—	—	—	90	—	—	—	ns
	4.5	12	—	12	—	—	—	15	—	15	—	—	18	—	18	—	
	6	10	—	—	—	—	—	13	—	—	—	—	15	—	—	—	
Hold Time, D <sub>n</sub> to LD	t <sub>H</sub>	2	30	—	—	—	—	40	—	—	—	—	45	—	—	—	ns
	4.5	6	—	8	—	—	—	8	—	10	—	—	9	—	12	—	
	6	5	—	—	—	—	—	7	—	—	—	—	8	—	—	—	
Latch Disable Pulse Width,	t <sub>W</sub>	2	50	—	—	—	—	65	—	—	—	—	75	—	—	—	ns
	4.5	10	—	10	—	—	—	13	—	13	—	—	15	—	15	—	
	6	9	—	—	—	—	—	11	—	—	—	—	13	—	—	—	

# CD54/74HC4543 CD54/74HCT4543

## STATIC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	CD74HC4543/CD54HC4543										CD74HCT4543/CD54HCT4543								UNITS	
	TEST CONDITIONS			74HC/54HC TYPES			74HC TYPES		54HC TYPES		TEST CONDITIONS		74HCT/54HCT TYPES			74HCT TYPES		54HCT TYPES		
	V <sub>I</sub> V	I <sub>O</sub> mA	V <sub>CC</sub> V	+25°C			-40/ +85°C		-55/ +125°C		V <sub>I</sub> V	V <sub>CC</sub> V	+25°C			-40/ +85°C		-55/ +125°C		
				Min	Typ	Max	Min	Max	Min	Max			Min	Typ	Max	Min	Max	Min		Max
High-Level Input Voltage V <sub>IH</sub>			2	1.5	—	—	1.5	—	1.5	—	—	4.5	2	—	—	2	—	2	—	V
			4.5	3.15	—	—	3.15	—	3.15	—	to	5.5								
			6	4.2	—	—	4.2	—	4.2	—										
Low-Level Input Voltage V <sub>IL</sub>			2	—	—	0.5	—	0.5	—	0.5	—	4.5	—	—	0.8	—	0.8	—	0.8	V
			4.5	—	—	1.35	—	1.35	—	1.35	—	to	5.5							
			6	—	—	1.8	—	1.8	—	1.8	—									
High-Level Output Voltage V <sub>OH</sub> CMOS Loads	V <sub>IL</sub> or V <sub>IH</sub>	-0.02	2	1.9	—	—	1.9	—	1.9	—	V <sub>IL</sub> or V <sub>IH</sub>	4.5	4.4	—	—	4.4	—	4.4	—	V
			4.5	4.4	—	—	4.4	—	4.4	—										
			6	5.9	—	—	5.9	—	5.9	—										
TTL Loads Non-Standard Output	V <sub>IL</sub> or V <sub>IH</sub>	-1	4.5	3.98	—	—	3.84	—	3.7	—	V <sub>IL</sub> or V <sub>IH</sub>	4.5	3.98	—	—	3.84	—	3.7	—	V
			6	5.48	—	—	5.34	—	5.2	—										
Low-Level Output Voltage V <sub>OL</sub> CMOS Loads	V <sub>IL</sub> or V <sub>IH</sub>	0.02	2	—	—	0.1	—	0.1	—	0.1	V <sub>IL</sub> or V <sub>IH</sub>	4.5	—	—	0.1	—	0.1	—	0.1	V
			4.5	—	—	0.1	—	0.1	—	0.1										
			6	—	—	0.1	—	0.1	—	0.1										
TTL Loads Non-Standard Output	V <sub>IL</sub> or V <sub>IH</sub>	1	4.5	—	—	0.26	—	0.33	—	0.4	V <sub>IL</sub> or V <sub>IH</sub>	4.5	—	—	0.26	—	0.33	—	0.4	V
			6	—	—	0.26	—	0.33	—	0.4										
Input Leakage Current I <sub>I</sub>	V <sub>CC</sub> or Gnd		6	—	—	±0.1	—	±1	—	±1	Any Voltage Between V <sub>CC</sub> & Gnd	5.5	—	—	±0.1	—	±1	—	±1	μA
Quiescent Device Current I <sub>CC</sub>	V <sub>CC</sub> or Gnd	0	6	—	—	8	—	80	—	160	V <sub>CC</sub> or Gnd	5.5	—	—	8	—	80	—	160	μA
Additional Quiescent Device Current per input pin: 1 unit load ΔI <sub>CC</sub> *											V <sub>CC</sub> -2.1	4.5 to 5.5	—	100	360	—	450	—	490	μA

\*For dual-supply systems theoretical worst case (V<sub>I</sub> = 2.4 V, V<sub>CC</sub> = 5.5 V) specification is 1.8 mA.

HCT Input Loading Table

Input	Unit Loads*
D0, D1, D2	1
D3, BI	0.5
PH	1.25
LD	1.5

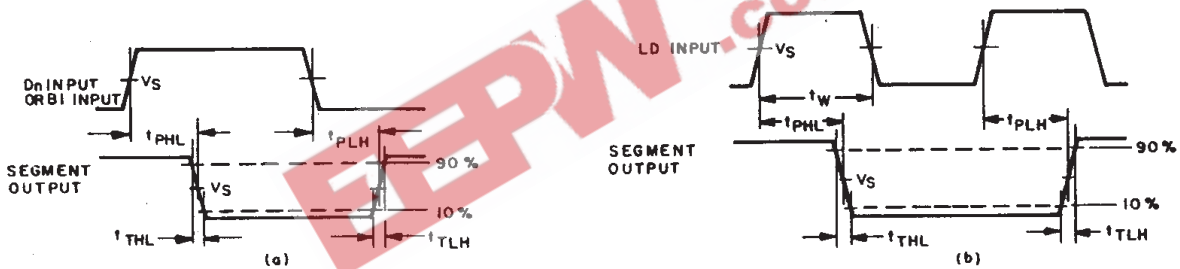
\*Unit Load is ΔI<sub>CC</sub> limit specified in Static Characteristics Chart, e.g., 360 μA max. @ 25°C.

Technical Data

**CD54/74HC4543**  
**CD54/74HCT4543**

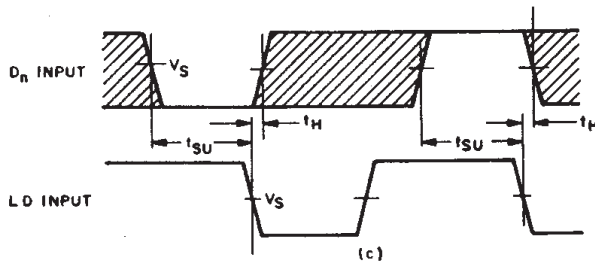
SWITCHING CHARACTERISTICS ( $C_L=50$  pF, Input  $t_r, t_f=6$  ns)

CHARACTERISTIC	$V_{CC}$	LIMITS												UNITS	
		25°C				-40°C to +85°C				-55°C to +125°C					
		HC		HCT		74HC		74HCT		54HC		54HCT			
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.		
Propagation Delay, $D_n$ to Output	$t_{PLH}$	2	—	340	—	—	—	425	—	—	—	510	—	—	ns
	$t_{PHL}$	4.5	—	68	—	80	—	85	—	100	—	102	—	120	
		6	—	58	—	—	—	72	—	—	—	87	—	—	
LD to Output	$t_{PLH}$	2	—	370	—	—	—	465	—	—	—	555	—	—	ns
	$t_{PHL}$	4.5	—	74	—	77	—	93	—	96	—	111	—	116	
		6	—	63	—	—	—	79	—	—	—	94	—	—	
BI to Output	$t_{PLH}$	2	—	265	—	—	—	330	—	—	—	400	—	—	ns
	$t_{PHL}$	4.5	—	53	—	66	—	66	—	83	—	80	—	99	
		6	—	45	—	—	—	56	—	—	—	68	—	—	
PH to Output	$t_{PLH}$	2	—	200	—	—	—	250	—	—	—	300	—	—	ns
	$t_{PHL}$	4.5	—	40	—	66	—	50	—	83	—	60	—	99	
		6	—	34	—	—	—	43	—	—	—	51	—	—	
Transition Time	$t_{TLH}$	2	—	250	—	—	—	315	—	—	—	375	—	—	ns
	$t_{THL}$	4.5	—	50	—	50	—	63	—	63	—	75	—	75	
		6	—	43	—	—	—	54	—	—	—	64	—	—	
Input Capacitance	$C_i$		—	10	—	10	—	10	—	10	—	10	—	10	pF



(a) WAVEFORMS SHOWING THE ADDRESS AND BLANKING ( $D_n$ , BI) TO OUTPUT PROPAGATION DELAYS AND THE OUTPUT TRANSITION TIMES.

(b) WAVEFORMS SHOWING THE LATCH DISABLE INPUT (LD) TO OUTPUT PROPAGATION DELAYS AND THE OUTPUT TRANSITION TIMES.



NOTE:  
THE SHADED AREAS INDICATE WHEN THE INPUT IS PERMITTED TO CHANGE FOR PREDICTABLE OUTPUT PERFORMANCE.

(c) WAVEFORMS SHOWING THE ADDRESS ( $D_n$ ) TO LATCH DISABLE (LD) INPUT SET-UP AND HOLD TIMES.

92CM-40103

	54/74HC	54/74HCT
Input Level	$V_{CC}$	3 V
Switching Voltage, $V_s$	50% $V_{CC}$	1.3 V

Fig. 2 - AC waveforms.

# CD54/74HC4543 CD54/74HCT4543

## APPLICATION CIRCUITS

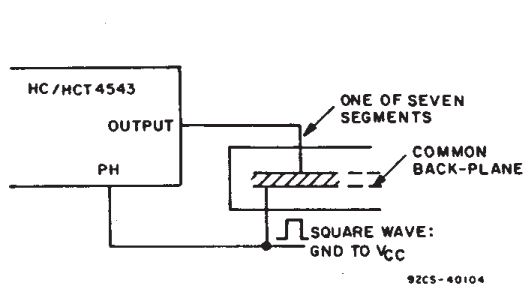


Fig. 3 - Connection to liquid-crystal (LCD) display readout.

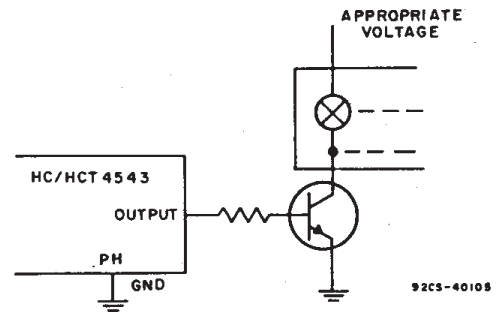


Fig. 4 - Connection to incandescent display readout.

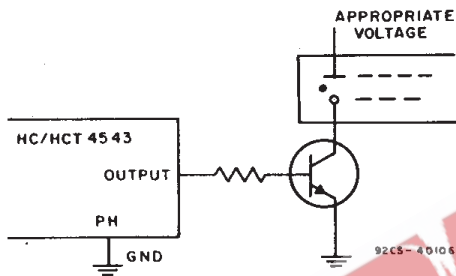


Fig. 5 - Connection to gas-discharge display readout.

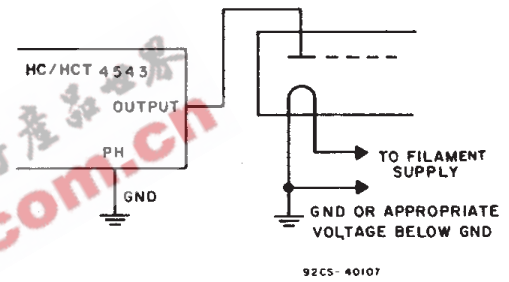


Fig. 6 - Connection to fluorescent display readout.

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